

Search Notes

Application/Control No.

10/803,310

Examiner

J. Pasterczyk

Applicant(s)/Patent under
Reexamination

MENG ET AL.

Art Unit

1755

SEARCHED

Class	Subclass	Date	Examiner
502	170	8/06	JP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR